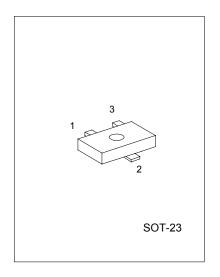
SCRs

DESCRIPTION

The XL1225/ML1225 silicon controlled rectifiers are high performance planner diffused PNPN devices. These parts are intended for low cost high volume applications.



1: GATE 2: ANODE 3: CATHODE

ABSOLUTE MAXIMUM RATINGS (Ta=25°C, unless otherwise specified)

PARAMETERS	PART NO.	SYMBOL	TEST CONDITION	MIN.	MAX.	UNITS
Repetitive Peak Off-State Voltage	XL1225	VDRM	Tj=40 to 125°C (RGK =1k Ω)	400		V
	ML1225	VDRM		300		
On-State Current		IT(RMS)	Tc=40°C	8.0		Α
Average On-State Current		IT(AV)	Half Cycle=180°, Tc=40°C	0.5		Α
Peak Reverse Gate Voltage		VGRM	IGR=10uA	1		V
Peak Gate Current		IGM	10us Max.	0.1		Α
Gate Dissipation		PG(AV)	20ms Max.	100		mW
Operating Temperature		Tj		-40	125	°C
Storage Temperature		Tstg		-40	125	°C
Soldering Temperature		TSLD	1.6mm from case 10s Max.		250	°C

ELECTRICAL CHARACTERISTICS (Ta=25°C, unless otherwise specified)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	MAX	UNIT
Off state leakage current	IDRM	VDRM(RGK=1KΩ), Tj=125°C		0.1	mA
Off state leakage current	IDRM	VDRM(RGK=1KΩ), Tj=25°C		1.0	μΑ
On state voltage	VT	AT IT=0.4A		1.4	V
		AT IT=0.8A		2.2	
On state threshold voltage	VT(TO)	Tj=125°C		0.95	V
On state slops resistance	Rt	Tj=125°C		600	m
Gate trigger current	IGT	VD=7V		200	μА
Gate trigger voltage	VGT	VD=7V		8.0	V
Holding current	IH	RGK=1KΩ		5	mA
Latching current	IL	RGK=1KΩ		6	mA

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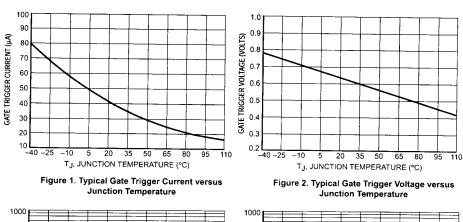
UTC XL/ML1225

SCR

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	MAX	UNIT
Critical rate of voltage rise	DV/DT	VD=0.67*VDRM(RGK=1KΩ),			V/μs
		Tj=125°C			
Critical rate of current rise	DV/DT	IG=10mA, dIG/dt=0.1A/μs,			A/μs
		Tj=125°C			
Gate controlled delay time	TGD	IG=10mA, dIG/dt=0.1A/μs,		2.2	μS
Commutated turn-off time	TG	Tj=85°C, VD=0.67*VDRM,		200	μS
		VR=35V, IT=IT(AV)			
Thermal resistance junc. to case	Rθ JC				K/W
Thermal resistance junc. to case	Rθ JA				K/W

CLASSIFICATION OF IGT

	- 01					
RANK	В	С	AA	AB	AC	AD
RANGE	50-100սA	100-200μΑ	8-15µA	15-20µA	20-25uA	25-50սA



HOLDING CURRENT (µA) 20 35 50 80 TJ, JUNCTION TEMPERATURE (°C)

Figure 3. Typical Holding Current versus Junction Temperature

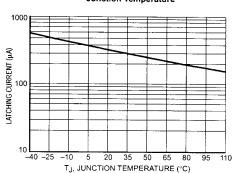


Figure 4. Typical Latching Current versus Junction Temperature

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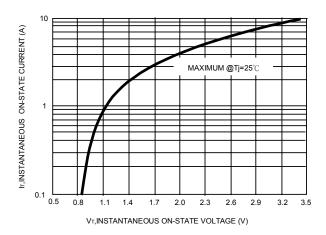


Figure 5. Typical On-State Characteristics

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